- Member of the Texas Instruments
   Widebus™ Family
- Operates at 2.3 V to 2.7 V for PC1600, PC2100, and PC2700; 2.5 V to 2.7 V for PC3200
- Pinout and Functionality Compatible With JEDEC Standard SSTV32852
- Pinout Optimizes 1U DDR DIMM Layout
- 600 ps Faster (Simultaneous Switching)
   Than the JEDEC Standard SSTV32852 in PC2700 DIMM Applications
- 1-to-2 Outputs Support Stacked DDR DIMMs
- One Device Per DIMM Required
- Output Edge-Control Circuitry Minimizes Switching Noise in an Unterminated Line

- Outputs Meet SSTL\_2 Class I Specifications
- Supports SSTL\_2 Data Inputs
- Differential Clock (CLK and CLK) Inputs
- Supports LVCMOS Switching Levels on the RESET Input
- RESET Input Disables Differential Input Receivers, Resets All Registers, and Forces All Outputs Low
- Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II
- ESD Protection Exceeds JESD 22
  - 2000-V Human-Body Model (A114-A)
  - 200-V Machine Model (A115-A)
  - 1000-V Charged-Device Model (C101)

## description/ordering information

This 24-bit to 48-bit registered buffer is designed for 2.3-V to 2.7-V V<sub>CC</sub> operation.

All inputs are SSTL\_2, except the LVCMOS reset (RESET) input. All outputs are edge-controlled circuits, optimized for unterminated DIMM loads, and meet SSTL\_2 Class I specifications.

The SN74SSTVF32852 operates from a differential clock (CLK and CLK). Data are registered at the crossing of CLK going high and CLK going low.

The device supports low-power standby operation. When RESET is low, the differential input receivers are disabled, and undriven (floating) data, clock, and reference voltage (V<sub>REF</sub>) inputs are allowed. In addition, when RESET is low, all registers are reset and all outputs are forced low. The LVCMOS RESET input always must be held at a valid logic high or low level.

To ensure defined outputs from the register before a stable clock has been supplied, RESET must be held in the low state during power up.

#### ORDERING INFORMATION

TA	PACKAGE <sup>†</sup>		ORDERABLE PART NUMBER	TOP-SIDE MARKING
0°C to 70°C	LFBGA – GKF	Tape and reel	SN74SSTVF32852KR	SVF852

<sup>†</sup>Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.



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# SN74SSTVF32852 24-BIT TO 48-BIT REGISTERED BUFFER WITH SSTL\_2 INPUTS AND OUTPUTS SCES426A - FEBRUARY 2003 - REVISED MARCH 2003

#### GKF PACKAGE (TOP VIEW)

		1	2	3	4	5	6
Α	/	$\bigcirc$	$\bigcirc$	0	$\bigcirc$	0	$\bigcirc$
В		Ö	Ŏ	O	Ŏ	Ŏ	$\circ$
С			Ō	Ō	Ō	Ō	$\circ$
D		$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$
Е		$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$
F		$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$
G		$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$
Н		$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$
J		$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$
K		$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$
L		$\bigcirc$	$\bigcirc$		$\bigcirc$	$\bigcirc$	$\bigcirc$
M		$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$
N		$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$
Р		$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$
R		$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$
T		0	$\bigcirc$	$\bigcirc$	0	$\bigcirc$	$\bigcirc$
U		$\bigcirc$	$\bigcirc$	$\bigcirc$	0	$\bigcirc$	$\bigcirc$
٧		0	0	0	0	0	$\bigcirc$
W		$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$	

# terminal assignments

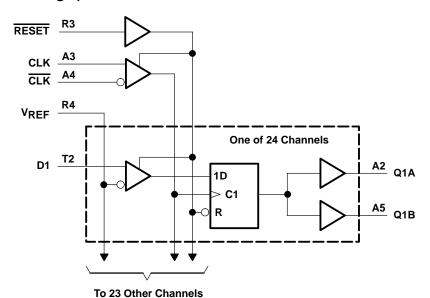
	1	2	3	4	5	6
Α	Q2A	Q1A	CLK	CLK	Q1B	Q2B
В	Q3A	$V_{DDQ}$	GND	GND	$V_{DDQ}$	Q3B
С	Q5A	Q4A	$V_{DDQ}$	$V_{DDQ}$	Q4B	Q5B
D	Q7A	Q6A	GND	GND	Q6B	Q7B
Ε	Q8A	GND	$V_{DDQ}$	$V_{DDQ}$	GND	Q8B
F	Q10A	Q9A	$V_{DDQ}$	$V_{DDQ}$	Q9B	Q10B
G	Q12A	Q11A	GND	GND	Q11B	Q12B
Н	Q13A	Vcc	$V_{DDQ}$	$V_{DDQ}$	Vcc	Q13B
J	Q14A	Q15A	GND	GND	Q15B	Q14B
K	Q17A	Q16A	$V_{DDQ}$	$V_{DDQ}$	Q16B	Q17B
L	Q18A	Q19A	GND	GND	Q19B	Q18B
M	Q20A	$V_{DDQ}$	GND	GND	$V_{DDQ}$	Q20B
N	Q22A	Q21A	$V_{DDQ}$	$V_{DDQ}$	Q21B	Q22B
Р	Q23A	$V_{DDQ}$	GND	GND	$V_{DDQ}$	Q23B
R	Q24A	Vcc	RESET	VREF	Vcc	Q24B
Т	D2	D1	D6	D18	D13	D14
U	D4	D3	D10	D22	D15	D16
٧	D5	D7	D11	D23	D19	D17
W	D8	D9	D12	D24	D21	D20

#### **FUNCTION TABLE**

	INPUTS							
RESET	CLK	Q						
Н	<b>↑</b>	$\downarrow$	Н	Н				
Н	$\uparrow$	$\downarrow$	L	L				
Н	L or H	L or H	Х	$Q_0$				
L	X or floating	X or floating	X or floating	L				



## logic diagram (positive logic)



## absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, V <sub>CC</sub> or V <sub>DDQ</sub>	
Input voltage range, V <sub>I</sub> (see Notes 1 and 2)	0.5 V to V <sub>CC</sub> + 0.5 V
Output voltage range, VO (see Notes 1 and 2)	–0.5 V to V <sub>DDQ</sub> + 0.5 V
Input clamp current, I <sub>IK</sub> (V <sub>I</sub> < 0)	
Output clamp current, $I_{OK}$ ( $V_O < 0$ or $V_O > V_{DDQ}$ )	±50 mA
Continuous output current, $I_O$ ( $V_O = 0$ to $V_{DDQ}$ )	±50 mA
Continuous current through each V <sub>CC</sub> , V <sub>DDQ</sub> , or GND	±100 mA
Package thermal impedance, θ <sub>JA</sub> (see Note 3)	
Storage temperature range, T <sub>stg</sub>	–65°C to 150°C

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.
  - 2. This value is limited to 3.6 V maximum.
  - 3. The package thermal impedance is calculated in accordance with JESD 51-7.



## SN74SSTVF32852 24-BIT TO 48-BIT REGISTERED BUFFER WITH SSTL 2 INPUTS AND OUTPUTS

SCES426A - FEBRUARY 2003 - REVISED MARCH 2003

## recommended operating conditions (see Note 4)

			MIN	NOM	MAX	UNIT
Vcc	Supply voltage		$V_{DDQ}$		2.7	V
\/	Output aupply valtage	PC1600, PC2100, PC2700	2.3		2.7	V
VDDQ	Output supply voltage	PC3200	2.5		2.7	V
\/	Peterones voltage (\(\lambda = = -\lambda =	PC1600, PC2100, PC2700	1.15	1.25	1.35	V
VREF	Reference voltage ( $V_{REF} = V_{DDQ}/2$ )	PC3200	1.25	1.3	1.35	V
$V_{TT}$	Termination voltage		V <sub>REF</sub> -40mV	V <sub>REF</sub>	V <sub>REF</sub> +40mV	V
٧ <sub>I</sub>	Input voltage		0		VCC	V
VIH	AC high-level input voltage	Data inputs	V <sub>REF</sub> +310mV			V
VIL	AC low-level input voltage	Data inputs			V <sub>REF</sub> -310mV	V
VIH	DC high-level input voltage	Data inputs	V <sub>REF</sub> +150mV			V
$V_{IL}$	DC low-level input voltage	Data inputs			V <sub>REF</sub> -150mV	V
$V_{IH}$	High-level input voltage	RESET	1.7			V
V <sub>IL</sub>	Low-level input voltage	RESET			0.7	V
VICR	Common-mode input voltage range	CLK, CLK	0.97		1.53	V
V <sub>I(PP)</sub>	Peak-to-peak input voltage	CLK, CLK	360			mV
ЮН	High-level output current				-8	A
loL	Low-level output current				8	mA
T <sub>A</sub>	Operating free-air temperature		0		70	°C

NOTE 4: The RESET input of the device must be held at valid logic voltage levels (not floating) to ensure proper device operation. The differential inputs must not be floating unless RESET is low. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

### electrical characteristics for PC1600, PC2100, and PC2700 over recommended operating free-air temperature range (unless otherwise noted)

	PARAMETER	TEST CONDITIONS		v <sub>cc</sub> †	MIN	TYP‡	MAX	UNIT
VIK		I <sub>I</sub> = -18 mA		2.3 V			-1.2	V
Vall		I <sub>OH</sub> = -100 μA	I <sub>OH</sub> = -100 μA			0.2		V
VOH		I <sub>OH</sub> = -8 mA		2.3 V	1.95			V
Voi		I <sub>OL</sub> = 100 μA		2.3 V to 2.7 V			0.2	V
VOL		I <sub>OL</sub> = 8 mA	2.3 V			0.35	V	
IĮ	All inputs	$V_I = V_{CC}$ or GND	_	2.7 V			±5	μΑ
laa	Static standby	RESET = GND	10 - 0	2.7 V			10	μΑ
ICC	Static operating	$\overline{RESET} = V_{CC}, V_I = V_{IH(AC)} \text{ or } V_{IL(AC)}$	IO = 0	2.7 V			35	mA
	Dynamic operating – clock only	RESET = VCC, VI = VIH(AC) or VIL(AC), CLK and CLK switching 50% duty cycle				38		μΑ/ MHz
ICCD	Dynamic operating – per each data input	RESET = VCC, VI = VIH(AC) or VIL(AC), CLK and CLK switching 50% duty cycle, One data input switching at one-half clock frequency, 50% duty cycle	IO = 0	2.5 V		7		μΑ/ clock MHz/ D input
	Data inputs	$V_I = V_{REF} \pm 310 \text{ mV}$	2.5 V	2.8	3.3	3.8	pF	
Ci	CLK, CLK	$V_{ICR} = 1.25 \text{ V}, V_{I(PP)} = 360 \text{mV}$		2.5	3	3.5		
	RESET	V <sub>I</sub> = V <sub>CC</sub> or GND				4	4.5	

<sup>†</sup> For this test condition,  $V_{DDQ}$  always is equal to  $V_{CC}$ . ‡ All typical values are at  $V_{CC}$  = 2.5 V,  $T_A$  = 25°C.



### electrical characteristics for PC3200 over recommended operating free-air temperature range (unless otherwise noted)

	PARAMETER	TEST CONDITIONS		v <sub>cc</sub> †	MIN	TYP‡	MAX	UNIT
VIK		I <sub>I</sub> = -18 mA		2.5 V			-1.2	V
Va		I <sub>OH</sub> = -100 μA	2.5 V to 2.7 V	V <sub>DDQ</sub> -	0.2		V	
VOH		I <sub>OH</sub> = -8 mA		2.5 V	1.95			V
Vai		I <sub>OL</sub> = 100 μA		2.5 V to 2.7 V			0.2	V
VOL		I <sub>OL</sub> = 8 mA	2.5 V			0.35	V	
lį	All inputs	$V_I = V_{CC}$ or GND		2.7 V			±5	μΑ
laa	Static standby	RESET = GND	I <sub>O</sub> = 0	2.7 V			10	μΑ
lcc	Static operating	$\overline{RESET} = V_{CC}, V_I = V_{IH(AC)} \text{ or } V_{IL(AC)}$	IO = 0	2.7 V			35	mA
	Dynamic operating – clock only	RESET = V <sub>CC</sub> , V <sub>I</sub> = V <sub>IH(AC)</sub> or V <sub>IL(AC)</sub> , CLK and CLK switching 50% duty cycle				38		μΑ/ MHz
ICCD	Dynamic operating – per each data input	RESET = V <sub>CC</sub> , V <sub>I</sub> = V <sub>IH(AC)</sub> or V <sub>IL(AC)</sub> , CLK and CLK switching 50% duty cycle, One data input switching at one-half clock frequency, 50% duty cycle	IO = 0	2.6 V		7		μΑ/ clock MHz/ D input
	Data inputs	$V_I = V_{REF} \pm 310 \text{ mV}$	2.6 V	2.8	3.3	3.8	pF	
Ci	CLK, CLK	$V_{ICR} = 1.25 \text{ V}, V_{I(PP)} = 360 \text{mV}$		2.5	3	3.5		
RESET		V <sub>I</sub> = V <sub>CC</sub> or GND		3	4	4.5		

<sup>†</sup> For this test condition, VDDQ always is equal to VCC.

### timing requirements over recommended operating free-air temperature range (unless otherwise noted) (see Figure 1)

				V <sub>CC</sub> = ± 0.2	2.5 V V†	V <sub>CC</sub> = ± 0.1	2.6 V V†	UNIT
				MIN	MAX	MIN	MAX	
fclock	Clock frequency				500		500	MHz
t <sub>W</sub>	Pulse duration, CL	1		1		ns		
t <sub>act</sub>	Differential inputs		22		22	ns		
<sup>t</sup> inact	Differential inputs i	nactive time (see Note 6)			22		22	ns
	Setup time	Fast slew rate (see Notes 7 and 9)	D-1-1-1-1-1-1	0.75		0.75		no
t <sub>su</sub>	Setup time	Slow slew rate (see Notes 8 and 9)	Data before CLK↑, CLK↓	0.9		0.9		ns
<b>.</b>	Hold time	Fast slew rate (see Notes 7 and 9)	Data after CLK↑, CLK↓	0.75		0.75		no
t <sub>h</sub>	rioid time	Slow slew rate (see Notes 8 and 9)	Data affer CLNT, CLN	0.9		0.9		ns

† For this test condition, V<sub>DDQ</sub> always is equal to V<sub>CC</sub>.

NOTES: 5. V<sub>REF</sub> must be held at a valid input level and data inputs must be held low for a minimum time of t<sub>act</sub> max, after RESET is taken high.

- 6. VREF, data, and clock inputs must be held at valid voltage levels (not floating) for a minimum time of tinact max, after RESET is taken
- 7. For data signal input slew rate ≥1 V/ns.
- 8. For data signal input slew rate ≥0.5 V/ns and <1 V/ns.
- 9. CLK, CLK signals input slew rates are ≥1 V/ns.



<sup>‡</sup> All typical values are at  $V_{CC} = 2.6 \text{ V}$ ,  $T_A = 25^{\circ}\text{C}$ .

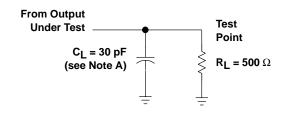
# SN74SSTVF32852 24-BIT TO 48-BIT REGISTERED BUFFER WITH SSTL\_2 INPUTS AND OUTPUTS SCES426A - FEBRUARY 2003 - REVISED MARCH 2003

## switching characteristics over recommended operating free-air temperature range (unless otherwise noted) (see Figure 1)

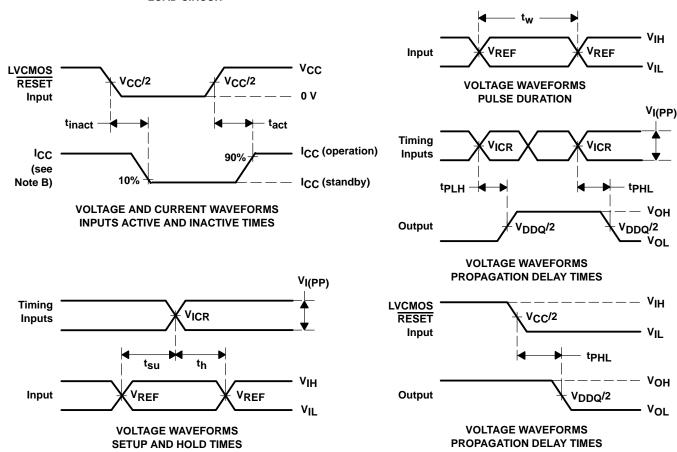
PARAMETER	FROM (INPUT)	TO (OUTPUT)	V <sub>CC</sub> =	2.5 V 2 V†	V <sub>CC</sub> = ± 0.1	2.6 V V†	UNIT
	(INFO1)	(6611 61)	MIN	MAX	MIN	MAX	
f <sub>max</sub>			500		500		MHz
t <sub>pd</sub>	CLK and CLK	Q	1.1	2.6	1.1	2.6	ns
<sup>t</sup> PHL	RESET	Q		5		5	ns

<sup>†</sup> For this test condition, VDDQ always is equal to VCC.

#### PARAMETER MEASUREMENT INFORMATION



#### **LOAD CIRCUIT**



NOTES: A.  $C_L$  includes probe and jig capacitance.

- B.  $I_{CC}$  tested with clock and data inputs held at  $V_{CC}$  or GND, and  $I_{O}$  = 0 mA.
- C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz, Z<sub>O</sub> = 50  $\Omega$ , input slew rate = 1 V/ns  $\pm$ 20% (unless otherwise noted).
- D. The outputs are measured one at a time with one transition per measurement.
- E.  $V_{REF} = V_{DDQ}/2$
- F.  $V_{IH} = V_{REF} + 310$  mV (ac voltage levels) for differential inputs.  $V_{IH} = V_{CC}$  for LVCMOS input.
- G.  $V_{IL} = V_{REF} 310 \text{ mV}$  (ac voltage levels) for differential inputs.  $V_{IL} = GND$  for LVCMOS input.
- H. tpLH and tpHL are the same as tpd.

Figure 1. Load Circuit and Voltage Waveforms



#### PACKAGE OPTION ADDENDUM

www.ti.com 8-Apr-2009

#### **PACKAGING INFORMATION**

Orderable Device	Status <sup>(1)</sup>	Package Type	Package Drawing	Pins	Package Qty	e Eco Plan <sup>(2)</sup>	Lead/Ball Finish	MSL Peak Temp <sup>(3)</sup>
74SSTVF32852ZKFR	ACTIVE	LFBGA	ZKF	114	1000	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR
SN74SSTVF32852KR	ACTIVE	BGA MI CROSTA R	GKF	114	1000	TBD	SNPB	Level-3-220C-168 HR

 $^{(1)}$  The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

**Pb-Free** (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

**Green (RoHS & no Sb/Br):** TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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## PACKAGE MATERIALS INFORMATION

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## TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
74SSTVF32852ZKFR	LFBGA	ZKF	114	1000	330.0	24.4	5.8	16.3	1.8	8.0	24.0	Q1
SN74SSTVF32852KR	BGA MI CROSTA R	GKF	114	1000	330.0	24.4	5.8	16.3	1.8	8.0	24.0	Q1

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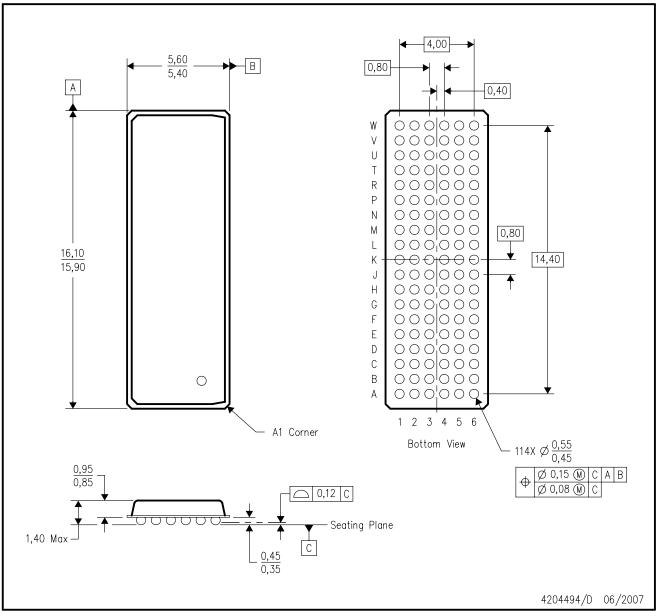


#### \*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
74SSTVF32852ZKFR	LFBGA	ZKF	114	1000	346.0	346.0	41.0
SN74SSTVF32852KR	BGA MICROSTAR	GKF	114	1000	346.0	346.0	41.0

# ZKF (R-PBGA-N114)

# PLASTIC BALL GRID ARRAY



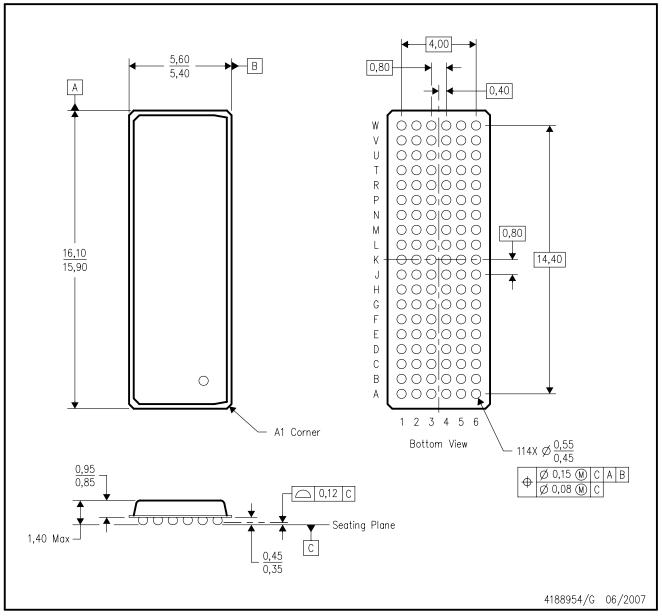
NOTES: A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.

- B. This drawing is subject to change without notice.
- C. Falls within JEDEC MO-205 variation DC.
- D. This package is lead-free. Refer to the 114 GKF package (drawing 4188954) for tin-lead (SnPb).



# GKF (R-PBGA-N114)

# PLASTIC BALL GRID ARRAY



NOTES: A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.

- B. This drawing is subject to change without notice.
- C. Falls within JEDEC MO-205 variation DC.
- D. This package is tin-lead (SnPb). Refer to the 114 ZKF package (drawing 4204494) for lead-free.



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